

Search Notes**Application/Control No.**

10/630,983

Examiner

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Applicant(s)/Patent under Reexamination

KOIKE, HIDEHARU

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	551,552, 309-311, 313,318	5/18/2005	HLN
	319,321		
	327,328		
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361	91.1,225		
257	355-357		
Update	Search	10/30/2005	HLN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search, see search history printout	9/29/2005	HLN
Shepardize Search, see search history printout	10/31/2005	HLN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner